

TABLE OF CONTENTS

Features	1
Applications	1
Functional Block DiagramS	1
General Description	1
Product Highlights	1
Revision History	2
Specifications.....	3
±15 V Dual Supply	3
±20 V Dual Supply	4
12 V Single Supply.....	5
36 V Single Supply.....	6

Continuous Current per Channel, Sx or D.....	7
Absolute Maximum Ratings	8
ESD Caution.....	8
Pin Configurations and Function Descriptions	9
Typical Performance Characteristics	10
Test Circuits.....	14
Terminology	17
Applications Information	18
Trench Isolation.....	18
Outline Dimensions	19
Ordering Guide	19

REVISION HISTORY

3/15—Rev. 0 to Rev. A

Added 8-Lead LFCSP.....	Universal
Added Figure 1; Renumbered Sequentially	1
Changes to Table 1.....	3
Changes to Table 2.....	4
Changes to Table 3.....	5
Changes to Table 4.....	6
Changed Continuous Current, Sx or D to 8-Lead MSOP, Table 5	7
Added Figure 3 and Table 8; Renumbered Sequentially	9
Changes to Table 7.....	9
Changes to Figure 5.....	10

Added Figure 23	13
Changes to Figure 24 Caption	14
Added Figure 25 and Figure 26	14
Deleted Figure 27; Renumbered Sequentially	14
Added Figure 32 and Figure 33	15
Changes to Terminology Section	17
Added Figure 37, Outline Dimensions.....	19
Changes to Ordering Guide	19

9/13—Revision 0: Initial Version

SPECIFICATIONS

±15 V DUAL SUPPLY

$V_{DD} = +15\text{ V} \pm 10\%$, $V_{SS} = -15\text{ V} \pm 10\%$, GND = 0 V, unless otherwise noted.

Table 1.

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			V_{DD} to V_{SS}	V	
On Resistance, R_{ON}	13.5 15 0.1	19	23	Ω typ Ω max Ω typ	$V_S = \pm 10\text{ V}$, $I_S = -10\text{ mA}$; see Figure 27 $V_{DD} = +13.5\text{ V}$, $V_{SS} = -13.5\text{ V}$ $V_S = \pm 10\text{ V}$, $I_S = -10\text{ mA}$
On-Resistance Match Between Channels, ΔR_{ON}	0.8 1.8 2.2	1.3	1.4	Ω max Ω typ Ω max	$V_S = \pm 10\text{ V}$, $I_S = -10\text{ mA}$
On-Resistance Flatness, $R_{FLAT(ON)}$		2.7	3.1		
LEAKAGE CURRENTS					
Source Off Leakage, I_S (Off)	±0.1			nA typ	$V_{DD} = +16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$ $V_S = \pm 10\text{ V}$, $V_D = \mp 10\text{ V}$; see Figure 24 and Figure 25
Drain Off Leakage, I_D (Off)	±0.25 ±0.1 ±0.4	±1	±10	nA max nA typ nA max	$V_S = \pm 10\text{ V}$, $V_D = \mp 10\text{ V}$; see Figure 25
Channel On Leakage, I_D (On), I_S (On)	±0.1 ±0.4	±4	±10	nA typ nA max	$V_S = V_D = \pm 10\text{ V}$; see Figure 24 and Figure 26
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2.0	V min	
Input Low Voltage, V_{INL}			0.8	V max	
Input Current, I_{INL} or I_{INH}	0.002		±0.1	μA typ μA max	$V_{IN} = V_{GND}$ or V_{DD}
Digital Input Capacitance, C_{IN}	6			pF typ	
DYNAMIC CHARACTERISTICS¹					
Transition Time, $t_{TRANSITION}$	217 260	310	336	ns typ ns max	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$ $V_S = 10\text{ V}$; see Figure 32
t_{ON} (EN)	179 212	261	298	ns typ ns max	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$ $V_S = 10\text{ V}$; see Figure 33
t_{OFF} (EN)	153 176	195	209	ns typ ns max	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$ $V_S = 10\text{ V}$; see Figure 33
Break-Before-Make Time Delay, t_D	86		45	ns typ ns min	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$ $V_S = 10\text{ V}$; see Figure 34
Charge Injection, Q_{INJ}	130			pC typ	$V_S = 0\text{ V}$, $R_S = 0\ \Omega$, $C_L = 1\text{ nF}$; see Figure 35
Off Isolation	−60			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 29
Channel-to-Channel Crosstalk	−80			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 28
Total Harmonic Distortion + Noise	0.01			% typ	$R_L = 1\text{ k}\Omega$, 15 V p-p, $f = 20\text{ Hz}$ to 20 kHz; see Figure 30
−3 dB Bandwidth	190			MHz typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$; see Figure 31
Insertion Loss	−0.8			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 31
C_S (Off)	12			pF typ	$V_S = 0\text{ V}$, $f = 1\text{ MHz}$
C_D (Off)	23			pF typ	$V_S = 0\text{ V}$, $f = 1\text{ MHz}$
C_D (On), C_S (On)	55			pF typ	$V_S = 0\text{ V}$, $f = 1\text{ MHz}$
POWER REQUIREMENTS					
I_{DD}	45 55		70	μA typ μA max	$V_{DD} = +16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$ Digital inputs = 0 V or V_{DD}
I_{SS}	0.001		1	μA typ μA max	Digital inputs = 0 V or V_{DD}
V_{DD}/V_{SS}			±9/±22	V min/V max	GND = 0 V

¹ Guaranteed by design; not subject to production test.

±20 V DUAL SUPPLY

$V_{DD} = +20\text{ V} \pm 10\%$, $V_{SS} = -20\text{ V} \pm 10\%$, GND = 0 V, unless otherwise noted.

Table 2.

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			V _{DD} to V _{SS}	V	
On Resistance, R _{ON}	12.5	18	22	Ω typ	V _S = ±15 V, I _S = −10 mA; see Figure 27 V _{DD} = +18 V, V _{SS} = −18 V
	14			Ω max	
On-Resistance Match Between Channels, ΔR _{ON}	0.1			Ω typ	V _S = ±15 V, I _S = −10 mA
On-Resistance Flatness, R _{FLAT (ON)}	0.8	1.3	1.4	Ω max	V _S = ±15 V, I _S = −10 mA
	2.3			Ω typ	
	2.7	3.3	3.7	Ω max	
LEAKAGE CURRENTS					
Source Off Leakage, I _S (Off)	±0.1			nA typ	V _{DD} = +22 V, V _{SS} = −22 V V _S = ±15 V, V _D = ∓ 15 V; see Figure 24 and Figure 25
Drain Off Leakage, I _D (Off)	±0.25	±1	±10	nA max	V _S = ±15 V, V _D = ∓ 15 V; see Figure 25
	±0.1			nA typ	
Channel On Leakage, I _D (On), I _S (On)	±0.4	±4	±10	nA max	V _S = V _D = ±15 V; see Figure 24 and Figure 26
	±0.1			nA typ	
	±0.4	±4	±10	nA max	
DIGITAL INPUTS					
Input High Voltage, V _{INH}			2.0	V min	V _{IN} = V _{GND} or V _{DD}
Input Low Voltage, V _{INL}			0.8	V max	
Input Current, I _{INL} or I _{INH}	0.002		±0.1	μA typ	
				μA max	
Digital Input Capacitance, C _{IN}	6			pF typ	
DYNAMIC CHARACTERISTICS ¹					
Transition Time, t _{TRANSITION}	200	279	294	ns typ	R _L = 300 Ω, C _L = 35 pF V _S = 10 V; see Figure 32
	235			ns max	
t _{ON} (EN)	199	300	344	ns typ	R _L = 300 Ω, C _L = 35 pF V _S = 10 V; see Figure 33
	239			ns max	
t _{OFF} (EN)	157	208	227	ns typ	R _L = 300 Ω, C _L = 35 pF V _S = 10 V; see Figure 33
	185			ns max	
Break-Before-Make Time Delay, t _D	77		46	ns typ	R _L = 300 Ω, C _L = 35 pF V _S = 10 V; see Figure 34
				ns min	
Charge Injection, Q _{INJ}	160			pC typ	V _S = 0 V, R _S = 0 Ω, C _L = 1 nF; see Figure 35
Off Isolation	−60			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz; see Figure 29
Channel-to-Channel Crosstalk	−80			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz; see Figure 28
Total Harmonic Distortion + Noise	0.01			% typ	R _L = 1 kΩ, 20 V p-p, f = 20 Hz to 20 kHz; see Figure 30
−3 dB Bandwidth	190			MHz typ	R _L = 50 Ω, C _L = 5 pF; see Figure 31
Insertion Loss	−0.7			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz; see Figure 31
C _S (Off)	11			pF typ	V _S = 0 V, f = 1 MHz
C _D (Off)	22			pF typ	V _S = 0 V, f = 1 MHz
C _D (On), C _S (On)	55			pF typ	V _S = 0 V, f = 1 MHz
POWER REQUIREMENTS					
I _{DD}	50	0.001	110	μA typ	V _{DD} = +22 V, V _{SS} = −22 V Digital inputs = 0 V or V _{DD}
	70			μA max	
I _{SS}			1	μA typ	Digital inputs = 0 V or V _{DD}
			±9/±22	μA max	
V _{DD} /V _{SS}				V min/V max	GND = 0 V

¹ Guaranteed by design; not subject to production test.

12 V SINGLE SUPPLY

$V_{DD} = 12\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$, $GND = 0\text{ V}$, unless otherwise noted.

Table 3.

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V_{DD}	V	
On Resistance, R_{ON}	26			Ω typ	$V_S = 0\text{ V to }10\text{ V}$, $I_S = -10\text{ mA}$; see Figure 27
	30	38	44	Ω max	$V_{DD} = 10.8\text{ V}$, $V_{SS} = 0\text{ V}$
On-Resistance Match Between Channels, ΔR_{ON}	0.1			Ω typ	$V_S = 0\text{ V to }10\text{ V}$, $I_S = -10\text{ mA}$
	1	1.5	1.6	Ω max	
On-Resistance Flatness, $R_{FLAT(ON)}$	5.5			Ω typ	$V_S = 0\text{ V to }10\text{ V}$, $I_S = -10\text{ mA}$
	6.8	8.3	12.3	Ω max	
LEAKAGE CURRENTS					
Source Off Leakage, I_S (Off)	± 0.1			nA typ	$V_{DD} = +13.2\text{ V}$, $V_{SS} = 0\text{ V}$ $V_S = 1\text{ V to }10\text{ V}$, $V_D = 10\text{ V to }1\text{ V}$; see Figure 24 and Figure 25
	± 0.25	± 1	± 10	nA max	
Drain Off Leakage, I_D (Off)	± 0.1			nA typ	$V_S = 1\text{ V to }10\text{ V}$, $V_D = 10\text{ V to }1\text{ V}$; see Figure 25
	± 0.4	± 4	± 10	nA max	
Channel On Leakage, I_D (On), I_S (On)	± 0.1			nA typ	$V_S = V_D = 1\text{ V to }10\text{ V}$; see Figure 24 and Figure 26
	± 0.4	± 4	± 10	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2.0	V min	
Input Low Voltage, V_{INL}			0.8	V max	
Input Current, I_{INL} or I_{INH}	0.002			μA typ	$V_{IN} = V_{GND}$ or V_{DD}
			± 0.1	μA max	
Digital Input Capacitance, C_{IN}	6			pF typ	
DYNAMIC CHARACTERISTICS¹					
Transition Time, $t_{TRANSITION}$	333			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	414	508	567	ns max	$V_S = 8\text{ V}$; see Figure 32
t_{ON} (EN)	327			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	410	526	612	ns max	$V_S = 8\text{ V}$; see Figure 33
t_{OFF} (EN)	166			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	200	528	611	ns max	$V_S = 8\text{ V}$; see Figure 33
Break-Before-Make Time Delay, t_D	176			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
			97	ns min	$V_S = 8\text{ V}$; see Figure 34
Charge Injection, Q_{INJ}	55			pC typ	$V_S = 6\text{ V}$, $R_S = 0\ \Omega$, $C_L = 1\text{ nF}$; see Figure 35
Off Isolation	−60			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 29
Channel-to-Channel Crosstalk	−80			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 28
Total Harmonic Distortion + Noise	0.03			% typ	$R_L = 1\text{ k}\Omega$, 6 V p-p , $f = 20\text{ Hz to }20\text{ kHz}$; see Figure 30
−3 dB Bandwidth	170			MHz typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$; see Figure 31
Insertion Loss	−1.7			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 31
C_S (Off)	15			pF typ	$V_S = 6\text{ V}$, $f = 1\text{ MHz}$
C_D (Off)	29			pF typ	$V_S = 0\text{ V}$, $f = 1\text{ MHz}$
C_D (On), C_S (On)	50			pF typ	$V_S = 6\text{ V}$, $f = 1\text{ MHz}$
POWER REQUIREMENTS					
I_{DD}	40			μA typ	$V_{DD} = 13.2\text{ V}$
	50		65	μA max	Digital inputs = 0 V or V_{DD}
V_{DD}			9/40	V min/V max	$GND = 0\text{ V}$, $V_{SS} = 0\text{ V}$

¹ Guaranteed by design; not subject to production test.

36 V SINGLE SUPPLY

$V_{DD} = 36\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$, $GND = 0\text{ V}$, unless otherwise noted.

Table 4.

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V_{DD}	V	
On Resistance, R_{ON}	14.5			Ω typ	$V_S = 0\text{ V to }30\text{ V}$, $I_S = -10\text{ mA}$; see Figure 27
	16	20	24	Ω max	$V_{DD} = 32.4\text{ V}$, $V_{SS} = 0\text{ V}$
On-Resistance Match Between Channels, ΔR_{ON}	0.1			Ω typ	$V_S = 0\text{ V to }30\text{ V}$, $I_S = -10\text{ mA}$
	0.8	1.3	1.4	Ω max	
On-Resistance Flatness, $R_{FLAT(ON)}$	3.5			Ω typ	$V_S = 0\text{ V to }30\text{ V}$, $I_S = -10\text{ mA}$
	4.3	5.5	6.5	Ω max	
LEAKAGE CURRENTS					
Source Off Leakage, I_S (Off)	± 0.1			nA typ	$V_{DD} = 39.6\text{ V}$, $V_{SS} = 0\text{ V}$ $V_S = 1\text{ V to }30\text{ V}$, $V_D = 30\text{ V to }1\text{ V}$; see Figure 24 and Figure 25
	± 0.25	± 1	± 10	nA max	
Drain Off Leakage, I_D (Off)	± 0.1			nA typ	$V_S = 1\text{ V to }30\text{ V}$, $V_D = 30\text{ V to }1\text{ V}$; see Figure 25
	± 0.4	± 4	± 10	nA max	
Channel On Leakage, I_D (On), I_S (On)	± 0.1			nA typ	$V_S = V_D = 1\text{ V to }30\text{ V}$; see Figure 24 and Figure 26
	± 0.4	± 4	± 10	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2.0	V min	
Input Low Voltage, V_{INL}			0.8	V max	
Input Current, I_{INL} or I_{INH}	0.002			μA typ	$V_{IN} = V_{GND}$ or V_{DD}
			± 0.1	μA max	
Digital Input Capacitance, C_{IN}	6			pF typ	
DYNAMIC CHARACTERISTICS¹					
Transition Time, $t_{TRANSITION}$	216			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	250	286	310	ns max	$V_S = 18\text{ V}$; see Figure 32
t_{ON} (EN)	199			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	232	279	315	ns max	$V_S = 18\text{ V}$; see Figure 33
t_{OFF} (EN)	160			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	193	284	315	ns max	$V_S = 18\text{ V}$; see Figure 33
Break-Before-Make Time Delay, t_D	80			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
			47	ns min	$V_S = 18\text{ V}$; see Figure 34
Charge Injection, Q_{INJ}	135			pC typ	$V_S = 18\text{ V}$, $R_S = 0\ \Omega$, $C_L = 1\text{ nF}$; see Figure 35
Off Isolation	−60			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 29
Channel-to-Channel Crosstalk	−80			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 28
Total Harmonic Distortion + Noise	0.01			% typ	$R_L = 1\text{ k}\Omega$, 18 V p-p , $f = 20\text{ Hz to }20\text{ kHz}$; see Figure 30
−3 dB Bandwidth	170			MHz typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$; see Figure 31
Insertion Loss	−1			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 31
C_S (Off)	14			pF typ	$V_S = 18\text{ V}$, $f = 1\text{ MHz}$
C_D (Off)	26			pF typ	$V_S = 0\text{ V}$, $f = 1\text{ MHz}$
C_D (On), C_S (On)	50			pF typ	$V_S = 18\text{ V}$, $f = 1\text{ MHz}$
POWER REQUIREMENTS					
I_{DD}	80			μA typ	$V_{DD} = 39.6\text{ V}$ Digital inputs = 0 V or V_{DD}
	100		130	μA max	
V_{DD}			9/40	V min/V max	$GND = 0\text{ V}$, $V_{SS} = 0\text{ V}$

¹ Guaranteed by design; not subject to production test.

CONTINUOUS CURRENT PER CHANNEL, Sx OR D

Table 5.

Parameter	25°C	85°C	125°C	Unit	Test Conditions/Comments
8-LEAD MSOP					$\theta_{JA} = 133.1^{\circ}\text{C/W}$
$V_{DD} = 15\text{ V}, V_{SS} = -15\text{ V}$	113	73	46	mA maximum	
$V_{DD} = 20\text{ V}, V_{SS} = -20\text{ V}$	118	76	47	mA maximum	
$V_{DD} = 12\text{ V}, V_{SS} = 0\text{ V}$	90	60	41	mA maximum	
$V_{DD} = 36\text{ V}, V_{SS} = 0\text{ V}$	116	74	46	mA maximum	
8-LEAD LFCSP					$\theta_{JA} = 60.88^{\circ}\text{C/W}$
$V_{DD} = 15\text{ V}, V_{SS} = -15\text{ V}$	156	92	52	mA maximum	
$V_{DD} = 20\text{ V}, V_{SS} = -20\text{ V}$	163	95	53	mA maximum	
$V_{DD} = 12\text{ V}, V_{SS} = 0\text{ V}$	126	78	48	mA maximum	
$V_{DD} = 36\text{ V}, V_{SS} = 0\text{ V}$	160	93	53	mA maximum	

ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$, unless otherwise noted.

Table 6.

Parameter	Rating
V_{DD} to V_{SS}	48 V
V_{DD} to GND	−0.3 V to +48 V
V_{SS} to GND	+0.3 V to −48 V
Analog Inputs ¹	$V_{SS} - 0.3\text{ V}$ to $V_{DD} + 0.3\text{ V}$ or 30 mA, whichever occurs first
Digital Inputs ¹	$V_{SS} - 0.3\text{ V}$ to $V_{DD} + 0.3\text{ V}$ or 30 mA, whichever occurs first
Peak Current, Sx or D Pins	410 mA (pulsed at 1 ms, 10% duty cycle maximum)
Continuous Current, Sx or D ²	Data + 15%
Temperature Range	
Operating	−40°C to +125°C
Storage	−65°C to +150°C
Junction Temperature	150°C
Thermal Impedance, θ_{JA}	
8-Lead MSOP (4-Layer Board)	133.1°C/W
8-Lead LFCSP	60.88°C/W
Reflow Soldering Peak Temperature, Pb Free	As per JEDEC J-STD-020
Human Body Model (HBM) ESD	8 kV

¹ Overvoltages at the IN, Sx, and D pins are clamped by internal diodes. Limit current to the maximum ratings given.

² See Table 5.

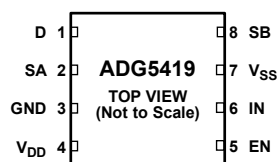
Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

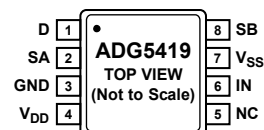


NOTES

1. EXPOSED PAD TIED TO SUBSTRATE, V_{SS} .

Figure 3. 8-Lead LFCSP Pin Configuration

11370-103



NOTES

1. NC = NO CONNECT. NOT INTERNALLY CONNECTED.

Figure 4. 8-Lead MSOP Pin Configuration

11370-002

Table 7. Pin Function Descriptions

Pin No.		Mnemonic	Description
LFCSP	MSOP		
1	1	D	Drain Terminal. This pin can be an input or output.
2	2	SA	Source Terminal. This pin can be an input or an output.
3	3	GND	Ground (0 V) Reference.
4	4	V_{DD}	Most Positive Power Supply Potential.
5	4	EN	Active High Digital Input. When this pin is low, the device is disabled and all switches are turned off. When this pin is high, the IN logic input determines the state of the switch.
6	6	IN	Logic Control Input.
7	7	V_{SS}	Most Negative Power Supply Potential.
8	8	SB	Source Terminal. This pin can be an input or an output.
	5	NC	No Connect. Not internally connected.
	Not applicable	EPAD	Exposed Pad. Exposed pad tied to substrate, V_{SS} .

Table 8. LFCSP Truth Table

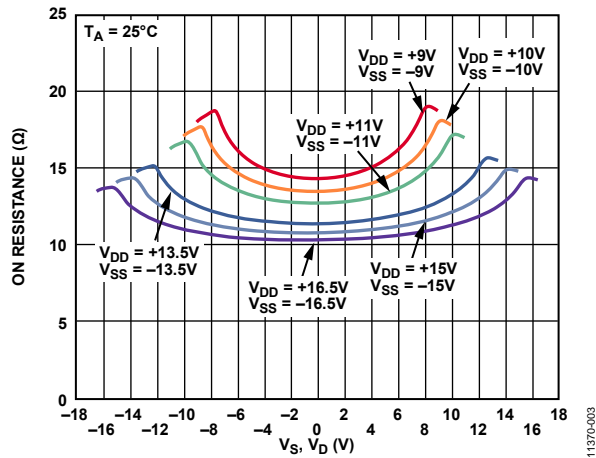
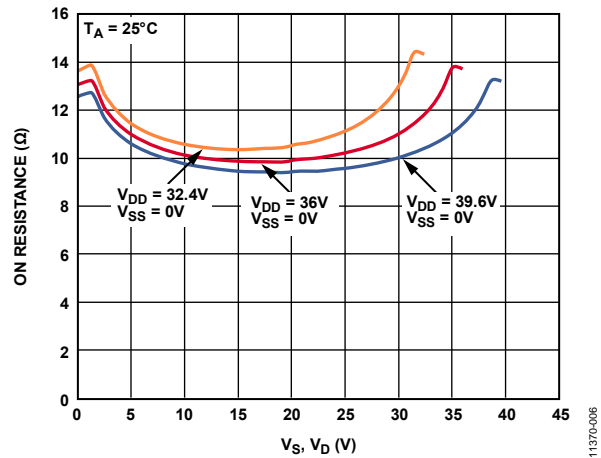
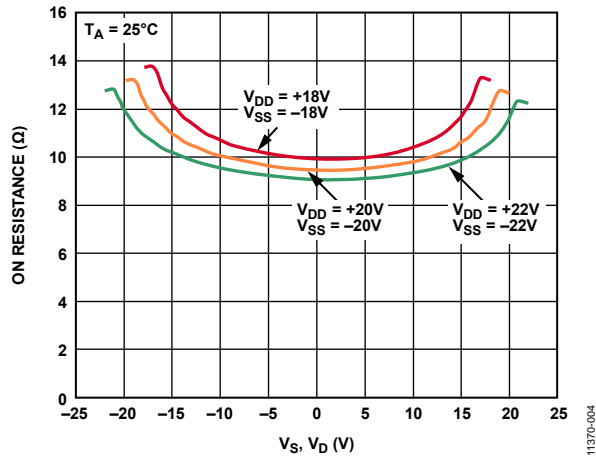
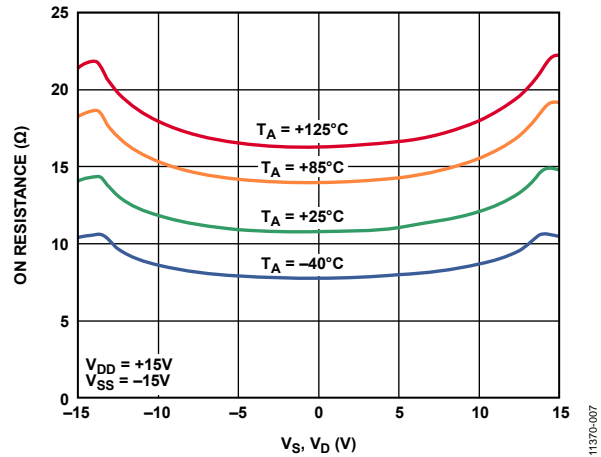
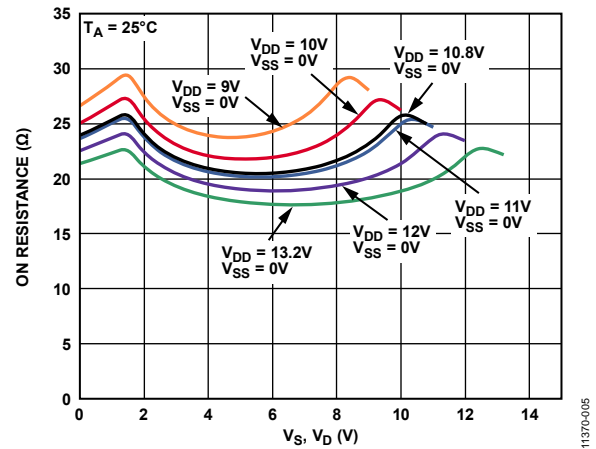
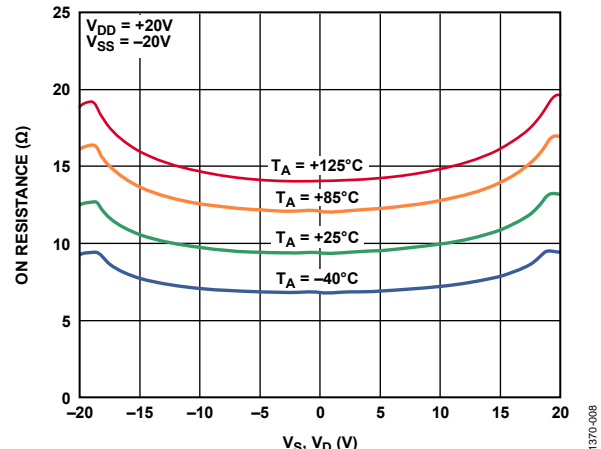
EN	IN	Switch A	Switch B
0	X ¹	Off	Off
1	0	On	Off
1	1	Off	On

¹ X = don't care.

Table 9. MSOP Truth Table

IN	Switch A	Switch B
0	On	Off
1	Off	On

TYPICAL PERFORMANCE CHARACTERISTICS

Figure 5. On Resistance as a Function of V_S , V_D Dual SupplyFigure 8. On Resistance as a Function of V_S , V_D (Single Supply)Figure 6. On Resistance as a Function of V_S , V_D Dual SupplyFigure 9. On Resistance as a Function of V_S (V_D) for Different Temperatures, ± 15 V Dual SupplyFigure 7. On Resistance as a Function of V_S , V_D (Single Supply)Figure 10. On Resistance as a Function of V_S (V_D) for Different Temperatures, ± 20 V Dual Supply

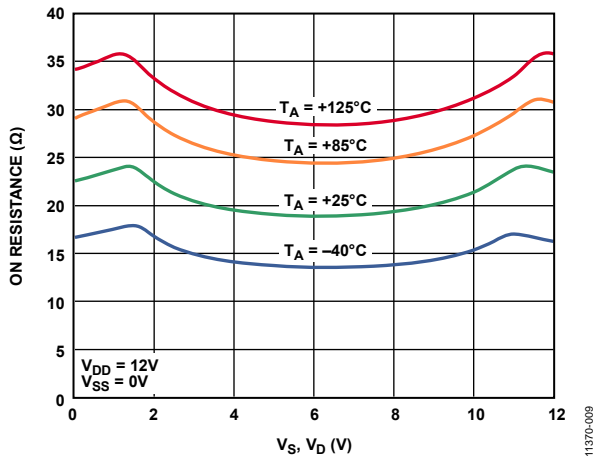


Figure 11. On Resistance as a Function of V_S (V_D) for Different Temperatures, 12 V Single Supply

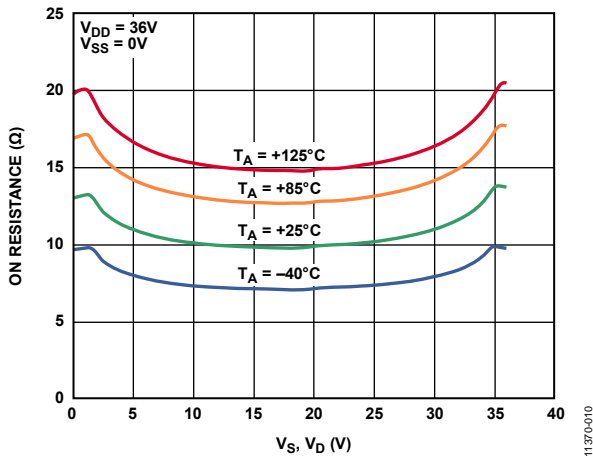


Figure 12. On Resistance as a Function of V_S (V_D) for Different Temperatures, 36 V Single Supply

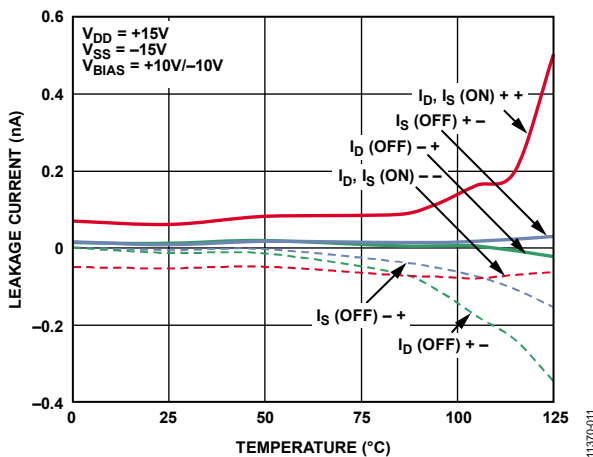


Figure 13. Leakage Currents as a Function of Temperature, ± 15 V Dual Supply

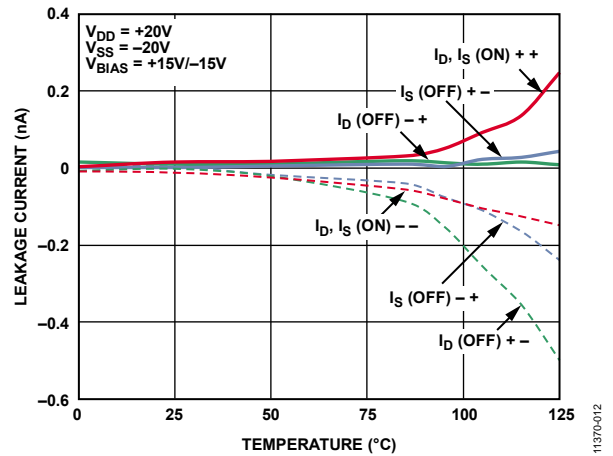


Figure 14. Leakage Currents as a Function of Temperature, ± 20 V Dual Supply

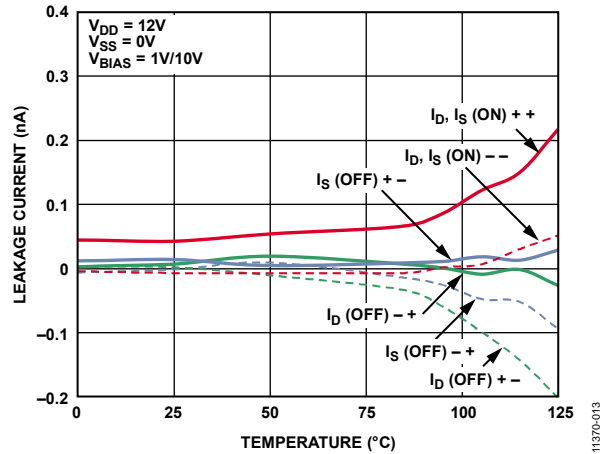


Figure 15. Leakage Currents as a Function of Temperature, 12 V Single Supply

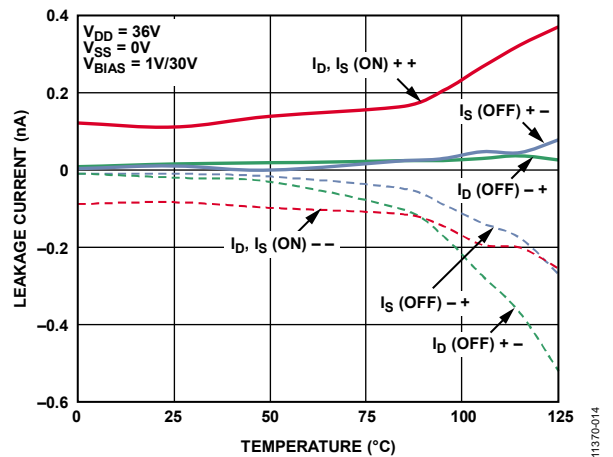


Figure 16. Leakage Currents as a Function of Temperature, 36 V Single Supply

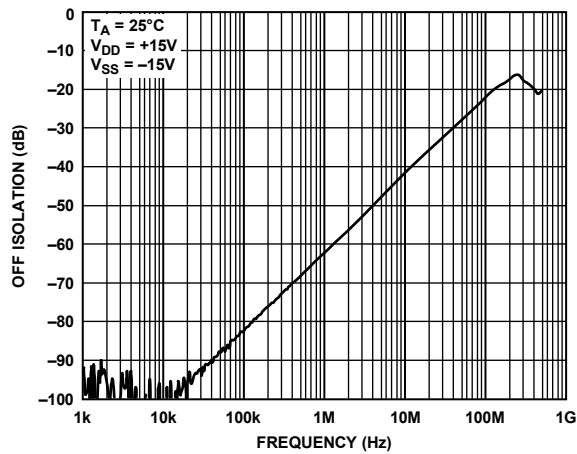


Figure 17. Off Isolation vs. Frequency

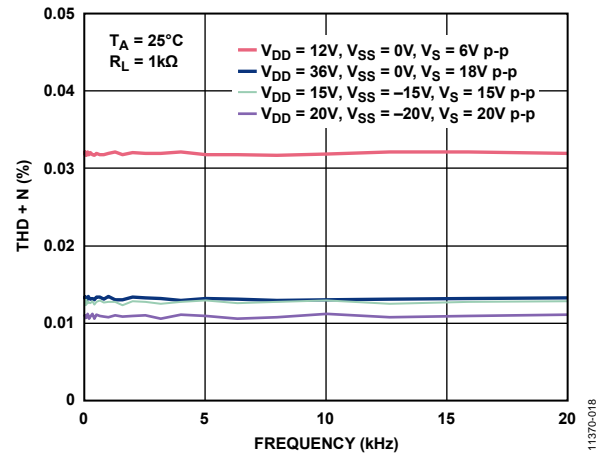


Figure 20. THD + N vs. Frequency

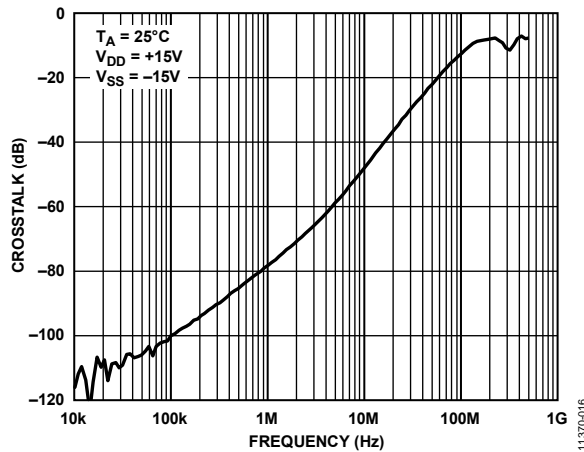


Figure 18. Crosstalk vs. Frequency

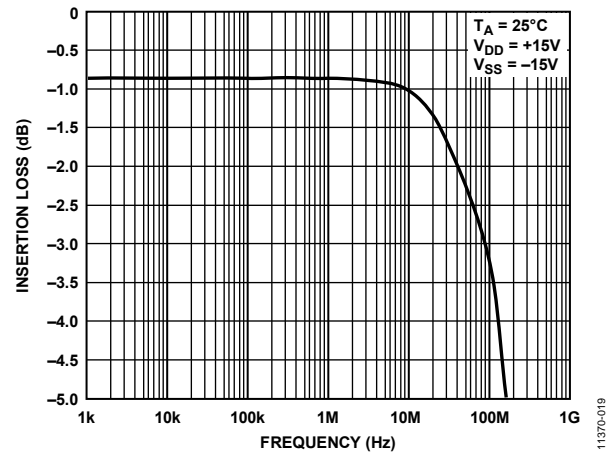


Figure 21. Bandwidth

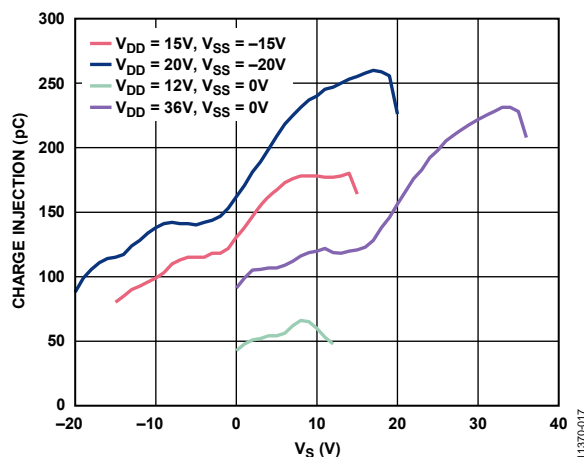
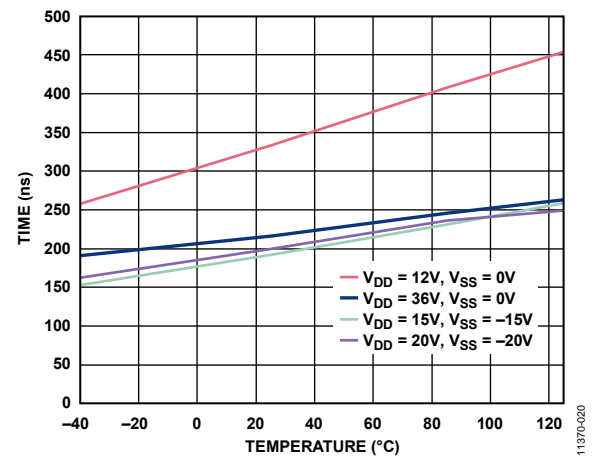


Figure 19. Charge Injection vs. Source Voltage

Figure 22. $t_{\text{TRANSITION}}$ Times vs. Temperature

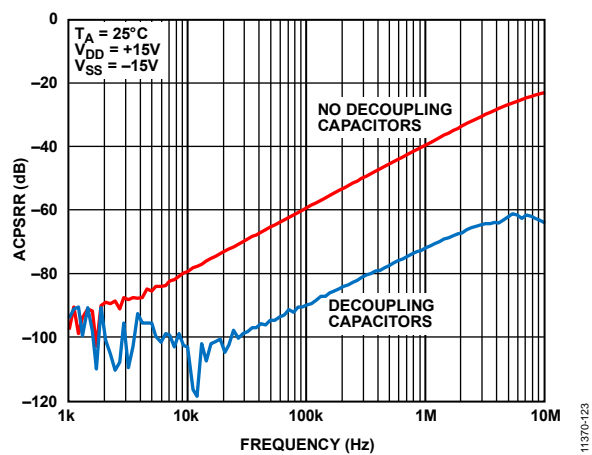


Figure 23. ACPSRR vs. Frequency

TEST CIRCUITS

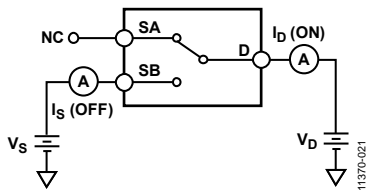


Figure 24. Channel On and Source Off Leakage (MSOP Only)

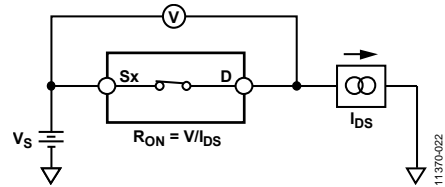


Figure 27. On Resistance

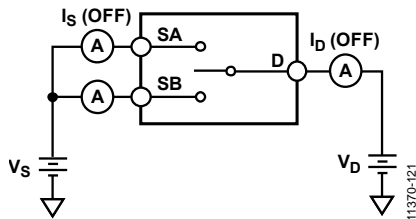


Figure 25. Off Leakage (LFCSP Only)

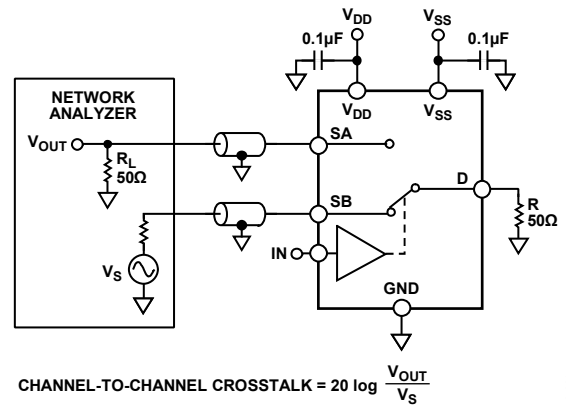


Figure 28. Channel-to-Channel Crosstalk

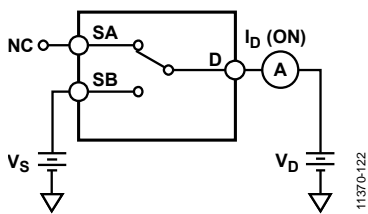


Figure 26. On Leakage (LFCSP Only)

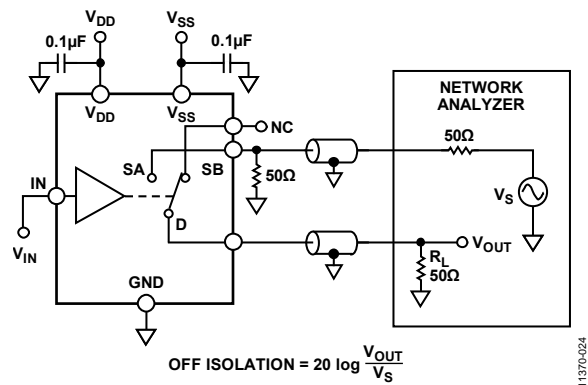


Figure 29. Off Isolation

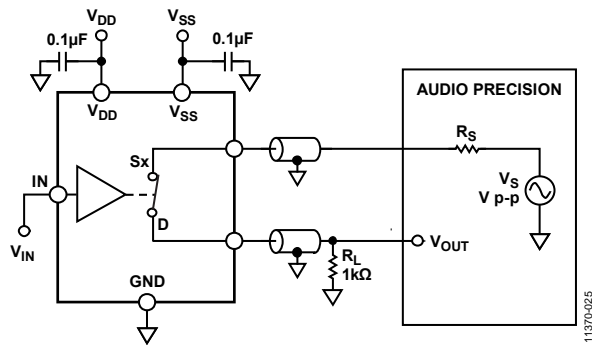


Figure 30. THD + Noise

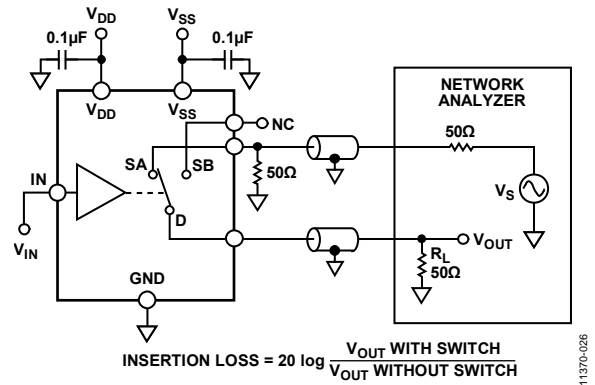
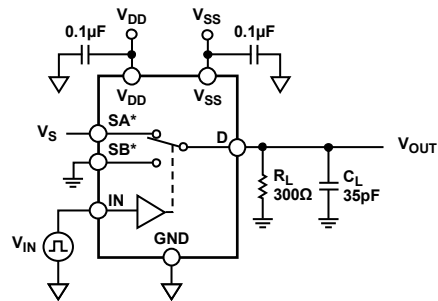
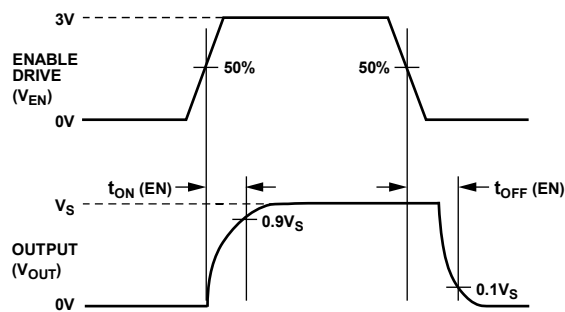
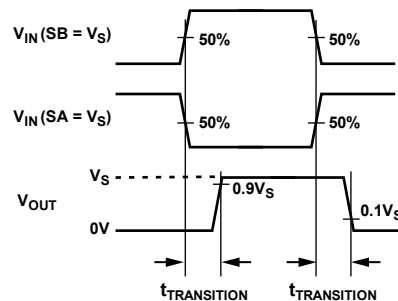
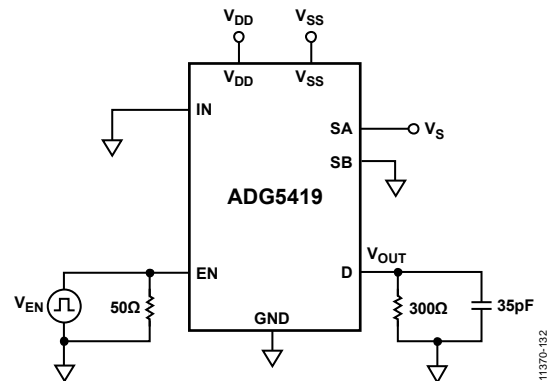
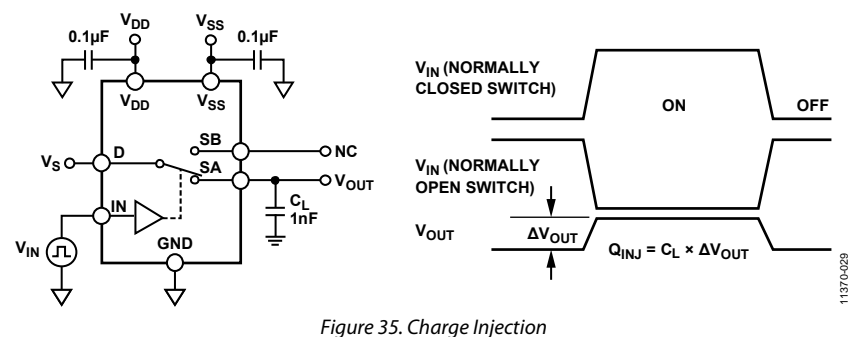
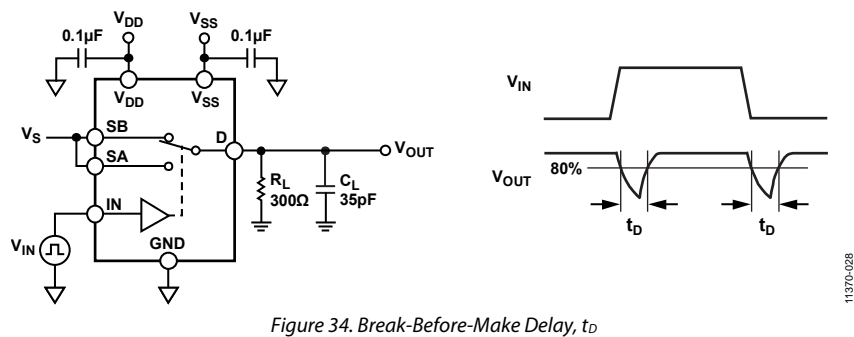


Figure 31. Bandwidth



*ALTERNATIVELY, SB CAN BE CONNECTED TO V_S WITH SA CONNECTED TO GROUND.

Figure 32. Transition Time, $t_{\text{TRANSITION}}$ Figure 33. Enable Delay, $t_{\text{ON}}(\text{EN})$, $t_{\text{OFF}}(\text{EN})$ (LFCSP Only)



TERMINOLOGY

I_{DD}

I_{DD} represents the positive supply current.

I_{SS}

I_{SS} represents the negative supply current.

V_D, V_S

V_D and V_S represent the analog voltage on Terminal D and Terminal S, respectively.

R_{ON}

R_{ON} is the ohmic resistance between Terminal D and Terminal S.

ΔR_{ON}

ΔR_{ON} represents the difference between the R_{ON} of any two channels.

R_{FLAT} (ON)

The difference between the maximum and minimum value of on resistance as measured over the specified analog signal range is represented by R_{FLAT} (ON).

I_S (Off)

I_S (Off) is the source leakage current with the switch off.

I_D (Off)

I_D (Off) is the drain leakage current with the switch off.

I_D (On), I_S (On)

I_D (On) and I_S (On) represent the channel leakage currents with the switch on.

V_{INL}

V_{INL} is the maximum input voltage for Logic 0.

V_{INH}

V_{INH} is the minimum input voltage for Logic 1.

I_{INL}, I_{INH}

I_{INL} and I_{INH} represent the low and high input currents of the digital inputs.

C_D (Off)

C_D (Off) represents the off switch drain capacitance, which is measured with reference to ground.

C_S (Off)

C_S (Off) represents the off switch source capacitance, which is measured with reference to ground.

C_D (On), C_S (On)

C_D (On) and C_S (On) represent on switch capacitances, which are measured with reference to ground.

C_{IN}

C_{IN} represents digital input capacitance.

t_{ON} (EN)

t_{ON} represents the delay time between the 50% and 90% points of the digital input and switch on condition. See Figure 33.

t_{OFF} (EN)

t_{OFF} represents the delay time between the 50% and 90% points of the digital input and switch off condition. See Figure 33.

t_{TRANSITION}

t_{TRANSITION} represents the delay time between the 50% and 90% points of the digital inputs and the switch on condition when switching from one address state to another.

t_D

t_D represents the off time measured between the 80% point of both switches when switching from one address state to another.

Off Isolation

Off isolation is a measure of unwanted signal coupling through an off channel.

Charge Injection

Charge injection is a measure of the glitch impulse transferred from the digital input to the analog output during switching.

Crosstalk

Crosstalk is a measure of unwanted signal that is coupled through from one channel to another as a result of parasitic capacitance.

Bandwidth

Bandwidth is the frequency at which the output is attenuated by 3 dB, from its dc level.

Total Harmonic Distortion + Noise (THD + N)

THD + N is the ratio of the harmonic amplitude plus noise of the signal to the fundamental.

AC Power Supply Rejection Ratio (ACPSRR)

ACPSRR measures the ability of a device to avoid coupling noise and spurious signals that appear on the supply voltage pin to the output of the switch. The dc voltage on the device is modulated by a sine wave of 0.62 V p-p. The ratio of the amplitude of signal on the output to the amplitude of the modulation is the ACPSRR. See Figure 23.

APPLICATIONS INFORMATION

The [ADG54xx](#) family of switches and multiplexers provide a robust solution for instrumentation, industrial, aerospace, and other harsh environments that are prone to latch-up, which is an undesirable high current state that can lead to device failure and persists until the power supply is turned off. The [ADG5419](#) high voltage switch allows single-supply operation from 9 V to 40 V and dual-supply operation from ± 9 V to ± 22 V. The [ADG5419](#) (as well as other select devices within this family) achieves an 8 kV human body model ESD rating, which provides a robust solution, eliminating the need for separate protection circuitry designs in some applications.

TRENCH ISOLATION

In the [ADG5419](#), an insulating oxide layer (trench) is placed between the NMOS and the PMOS transistors of each CMOS switch. Parasitic junctions, which occur between the transistors in junction-isolated switches, are eliminated, and the result is a completely latch-up immune switch.

In junction isolation, the N and P wells of the PMOS and NMOS transistors form a diode that is reverse-biased under normal operation. However, during overvoltage conditions, this diode can become forward-biased. The two transistors form a silicon-controlled rectifier (SCR) type circuit, causing a significant amplification of the current that, in turn, leads to latch-up. With trench isolation, this diode is removed, and the result is a latch-up immune switch.

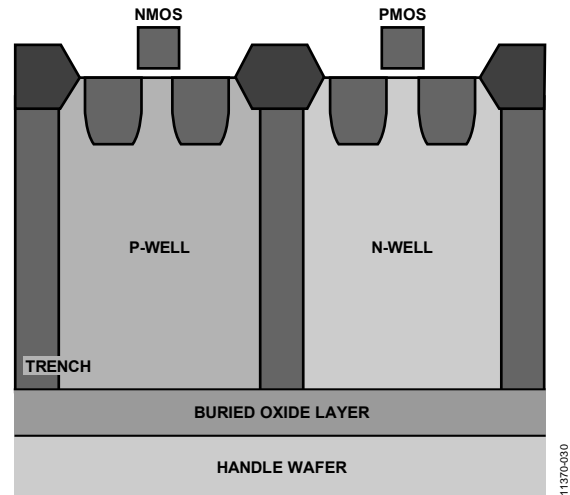


Figure 36. Trench Isolation

OUTLINE DIMENSIONS

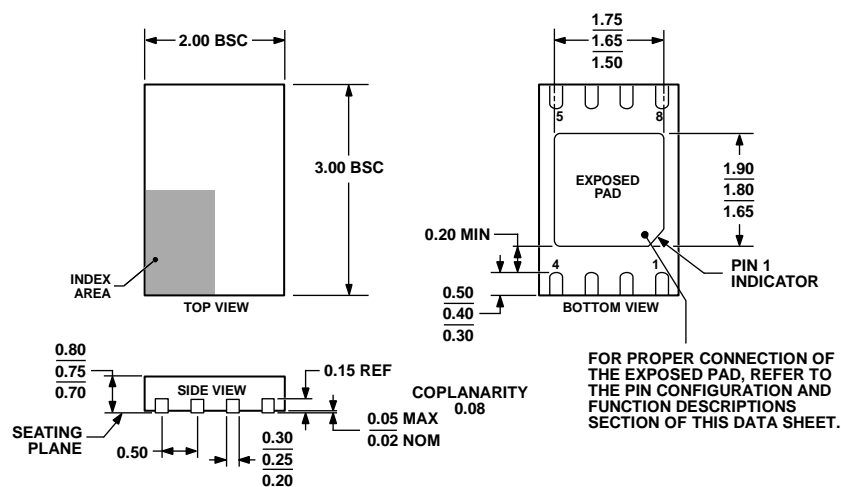


Figure 37. 8-Lead Lead Frame Chip Scale Package [LFCSP_WD]
2 mm × 3 mm Body, Very Very Thin, Dual Lead
(CP-8-4)

Dimensions shown in millimeters

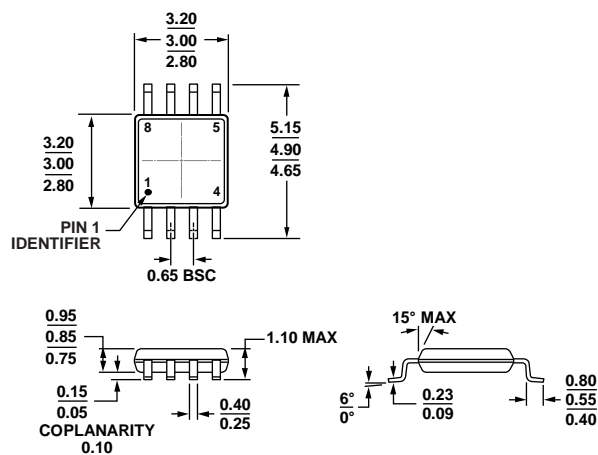


Figure 38. 8-Lead Mini Small Outline Package [MSOP]
(RM-8)

Dimensions shown in millimeters

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option	Branding
ADG5419BCPZ-RL7	−40°C to +125°C	8-Lead Lead Frame Chip Scale Package [LFCSP_WD]	CP-8-4	BL
ADG5419BRMZ	−40°C to +125°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	S48
ADG5419BRMZ-RL7	−40°C to +125°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	S48

¹ Z = RoHS Compliant Part.